

Notice of References Cited	Application/Control No. 10/553,501		Applicant(s)/Patent Under Reexamination LEE, BAEK-WOON	
	Examiner MY-CHAU T. TRAN		Art Unit 2629	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,833,888 B2	12-2004	Song et al.	349/106
*	B	US-6,891,522 B2	05-2005	Song et al.	345/87
*	C	US-2004/0239602 A1	12-2004	Kim et al.	345/087
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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